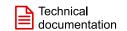
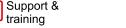
INA500











JAJSSK7B - DECEMBER 2023 - REVISED MARCH 2024

INA500

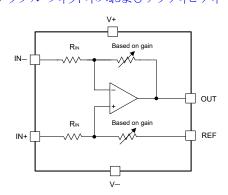
1MΩ 超の入力インピーダンス搭載、コストとサイズを最適化した低消費電 カ、1.7V~5.5V 差動アンプ

1 特長

- 小型、低消費電力、低コスト用に最適化
- >1MΩ 超高入力インピーダンス
- 3 つのゲイン オプション (G = 1、0.50、0.25)
- 8 ビット~12 ビットのシステムに対応する優れた精度
 - CMRR:87dB (標準値)
 - ゲイン誤差:±0.01% (標準値)
 - オフセット電圧:±0.70mV (標準値)
- 省スペースの 0.8mm² X2SON パッケージ
- 带域幅:125kHz (標準値)
- 20% 未満のオーバーシュートで 200pF を駆動 (標準
- 低い静止電流:13.5µA (標準値)
- 電源電圧範囲: 1.7V (±0.85V)~5.5V (±2.75V)
- 仕様温度範囲:-40℃~125℃

2 アプリケーション

- バッテリセル形成とテスト機器
- ストリング インバータ
- EV 充電ステーション向け電源モジュール
- バッテリエネルギー ストレージ システム
- 電動工具
- 産業用 AC-DC
- ウェアラブル フィットネスおよびアクティビティ モニタ



注:入力抵抗 (R_{IN}) 値は、INA500A が 1.08MΩ、INA500B が 1.44MΩ、INA500C が 1.68MΩ です。

INA500 の内部概略回路図

3 概要

INA500 は、オペアンプとマッチング抵抗を内蔵した差動 アンプで、3 つのゲイン オプションが用意されています。 INA500 A バージョンはゲイン オプション 1 を提供し、 INA500 B および INA500 C バージョンにはそれぞれ 0.50 および 0.25 のゲイン オプションがあります。

これらは、>1MΩ の入力インピーダンスと 13.5µA の低い 静止電流を持つ差動アンプ構成の電圧センシング INA です。このデバイスは 75dB の最小 CMRR、精度 ±0.05% の最大ゲイン誤差、G = 1 構成で 3.5mV の最大 オフセット (出力基準) を実現しています。このデバイス は、5.5V (±2.75V) の電源電圧で、G = 0.25 で最大 27.5V (±13.75V) の入力同相電圧を処理できます。上記 の仕様の組み合わせは、さまざまなレベル変換およびバッ テリ監視アプリケーション用に設計されています。

INA500 の高精度でマッチングされた内蔵抵抗により、高 精度で公差の小さい外付け抵抗が不要になるため、BOM のコストと基板面積を削減できます。INA500 は低速の 8 ビットから 12 ビットの A/D コンバータ (ADC) に直接接続 できるため、一般的なアンプやディスクリート抵抗を使用し た差動アンプのディスクリート実装の代替に最適です。 INA500 は、SOT-23、SC70 などの標準 6 ピン パッケー ジと、省スペースの X2SON パッケージで供給されます。

パッケージ情報

	· · · · · · · · · · · · · · · · · · ·						
部品番号(1)	バージョン	パッケージ (2)	パッケージ サイズ ⁽⁴⁾				
		DCK (SC70, 6)	2.1mm × 1.25mm				
	Α	DBV (SOT-23, 6)	2.9mm × 2.8mm				
INA500		DTQ (X2SON, 6) (3)	1mm × 0.8mm				
	В	DCK (SC70, 6)	2.1mm × 1.25mm				
		DBV (SOT-23, 6)	2.9mm × 2.8mm				
		DTQ (X2SON, 6) (3)	1mm × 0.8mm				
		DCK (SC70, 6)	2.1mm × 1.25mm				
	С	DBV (SOT-23, 6)	2.9mm × 2.8mm				
		DTQ (X2SON, 6) (3)	1mm × 0.8mm				

- 製品比較表を参照してください。 (1)
- (2) 詳細については、セクション 11 を参照してください。
- このパッケージはプレビューのみです。 (3)
- パッケージ サイズ (長さ×幅) は公称値であり、該当する場合はピ ンも含まれます



Table of Contents

	杜 F	
1	特長	1
2	アプリケーション	1
3	概要	1
4	Device Comparison Table	2
5	Pin Configuration and Functions	2
6	Specifications	4
	6.1 Absolute Maximum Ratings	
	6.2 ESD Ratings	
	6.3 Recommended Operating Conditions	4
	6.4 Thermal Information	
	6.5 Electrical Characteristics - INA500A	5
	6.6 Electrical Characteristics - INA500B	7
	6.7 Electrical Characteristics - INA500C	9
	6.8 Typical Characteristics	. 11
7	Detailed Description	
	7.1 Overview	. 26
	7.2 Functional Block Diagram	.26
	7.3 Feature Description	
	·	

7.4 Device Functional Modes	31
8 Application and Implementation	32
8.1 Application Information	32
8.2 Typical Applications	33
8.3 Power Supply Recommendations	35
8.4 Layout	36
9 Device and Documentation Support	38
9.1 Device Support	
9.2 Documentation Support	38
9.3ドキュメントの更新通知を受け取る方法	
9.4 サポート・リソース	38
9.5 Trademarks	38
9.6 静電気放電に関する注意事項	38
9.7 用語集	38
10 Revision History	38
11 Mechanical, Packaging, and Orderable	
Information	39

4 Device Comparison Table

	NO. OF		PACKAGE LEADS			
DEVICE	VERSION	CHANNELS SOT-23 DBV		SC70 DCK	X2SON DTQ ⁽¹⁾	
INA500	Α	1	6	6	6	
	В	1	6	6	6	
	С	1	6	6	6	

(1) Package is preview only.

5 Pin Configuration and Functions

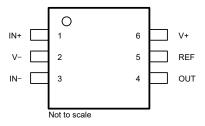


図 5-1. INA500 DCK Package, 6-Pin SC70 (Top View)

表 5-1. Pin Functions

Р	IN	TYPE(1)	DESCRIPTION	
NAME	SC70	ITPE	DESCRIPTION	
IN-	3	I	Negative (inverting) input	
IN+	1	I	Positive (non-inverting) input	
OUT	4	0	Dutput	
REF	5	I	Reference input	
V-	2	_	Negative supply	
V+	6	_	Positive supply	

Product Folder Links: INA500

(1) I = input, O = output

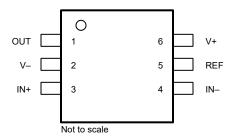


図 5-2. INA500 DBV Package, 6-Pin SOT-23 (Top View)

表 5-2. Pin Functions

P	PIN	TYPE ⁽¹⁾	DESCRIPTION	
NAME	SOT-23	1166,7	DESCRIPTION	
IN-	4	I	Negative (inverting) input	
IN+	3	I	ositive (noninverting) input	
OUT	1	0	utput	
REF	5	I	Reference input	
V-	2	_	Negative supply	
V+	6	_	Positive supply	

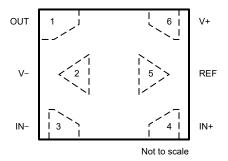


図 5-3. INA500 DTQ Package, 6-Pin X2SON (Top View)

表 5-3. Pin Functions

I	PIN	TYPE(1)	DESCRIPTION	
NAME	X2SON	ITPE\''	DESCRIPTION	
IN-	3	I	Negative (inverting) input	
IN+	4	I	ositive (noninverting) input	
OUT	1	0	utput	
REF	5	I	Reference input	
V-	2	_	Negative supply	
V+	6	_	Positive supply	

(1) I = input, O = output

English Data Sheet: SBOSAI9



6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

		MIN	MAX	UNIT
Supply voltage, $V_S = (V+) - (V-)$	Single Supply		6	V
	Dual Supply		±3	V
Signal input pins	Current	-10	10	mA
Output short-circuit ⁽²⁾		Continuous		
Operating Temperature, T _A		-55	150	
Junction Temperature, T _J			150	°C
Storage Temperature, T _{stg}		-65	150	

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

			VALUE	UNIT
V	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2500	V
V _(ESD)	Liectiostatic discriarge	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±1500	V

⁽¹⁾ JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT	
Supply voltage V = (V+) (V)	Single-supply	1.7	5.5	V	
Supply voltage $V_S = (V+) - (V-)$	Dual-supply	±0.85	±2.75	v	
C _{BYP}	Bypass capacitor on the power supply pins (1)	0.1		μF	
Specified temperature	Specified temperature	-40	125	°C	

⁽¹⁾ For C_{BYP}, use low-ESR ceramic capacitors between each supply pin and ground. Only one C_{BYP} is sufficient for single supply operation. Ensure that C_{BYP} is placed as close to the device as possible and the supply trace routes through C_{BYP} before reaching the supply pin.

6.4 Thermal Information

			INA500		
	THERMAL METRIC(1)	DCK (SC70)	DBV (SOT-23)	DTQ (X2SON)	UNIT
		6 PINS	6 PINS	6 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	200.2	195.9	TBD	°C/W
R _{0JC(top)}	Junction-to-case (top) thermal resistance	127.6	115.5	TBD	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	59.6	77.1	TBD	°C/W
ΨЈТ	Junction-to-top characterization parameter	42.6	52.2	TBD	°C/W
ΨЈВ	Junction-to-board characterization parameter	59.4	76.8	TBD	°C/W
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance	n/a	n/a	TBD	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application note.

Product Folder Links: INA500

English Data Sheet: SBOSAI9

⁽²⁾ Short-circuit to V_S / 2.

⁽²⁾ JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.



6.5 Electrical Characteristics - INA500A

For $V_S = (V+) - (V-) = 1.7V$ to 5.5V (±0.85V to ±2.75V) at $T_A = 25^{\circ}$ C, $V_{REF} = V_S / 2$, G = 1, $R_L = 100k\Omega$ connected to $V_S / 2$, $V_{CM} = (V_{IN+} + V_{IN-}) / 2 = V_S / 2$, $V_{IN} = (V_{IN+} - V_{IN-}) = 0$ V and $V_{OUT} = V_S / 2$ (unless otherwise noted)

J ,	PARAMETER	$2, V_{IN} = (V_{IN+} - V_{IN-}) = 0V$ ar TEST CONDIT	TIONS	MIN	TYP	MAX	UNIT
OFFSET	•						
	Offset voltage, RTO ⁽³⁾	V _S = 5.5V	T _A = 25°C		±0.70	±3.5	mV
/ _{oso}	Offset voltage over T, RTO ⁽³⁾	V _S = 5.5V	T _A = -40°C to 125°C			±3.6	mV
	Offset temp drift, RTO ⁽³⁾	V _S = 5.5V	T _A = -40°C to 125°C		±1.8	8.5	μV/°C
PSRR	Power-supply rejection ratio	V _S = 1.7V to 5.5V	T _A = 25°C		40	175	μV/V
NPUT II	MPEDANCE					'	
R _{IN-DM}	Differential Resistance				2160		kΩ
R _{IN-CM}	Common-mode Resistance				1080		kΩ
NPUT V	OLTAGE						
V _{CM}	Input common-mode Range	V _{REF} = V _S / 2		2*(V–) – V _{REF}		2*(V+) – V _{REF}	V
CMRR DC	Common-mode rejection ratio, RTO ⁽³⁾	V_{CM} = [2*(V-) - V_{REF}] to [2*(V+) - V_{REF} - 1.4V], High CMRR region	V _S = 5.5V, V _{REF} = V _S / 2	75	87		dB
CMRR DC	Common-mode rejection ratio, RTO ⁽³⁾	V_{CM} = [2*(V-) - V_{REF}] to [2*(V+) - V_{REF}], Rail-to-Rail CMRR region	V _S = 5.5V, V _{REF} = V _S / 2	62	77		dB
NOISE V	/OLTAGE						
∍ _{NI}	Output voltage noise		f = 1kHz		310		nV/√ H z
'NI	density		f = 10kHz		308		
E _{NI}	Output voltage noise	f _B = 0.1Hz to 10Hz			8		μV_{PP}
GAIN							
GE	Gain error ⁽²⁾	V _{REF} = V _S / 2	$V_O = (V-) + 0.1V$ to $(V+) - 0.1V$		±0.01	±0.05	%
	Gain drift vs temperature ⁽²⁾		$T_A = -40^{\circ}C \text{ to } 125^{\circ}C$			±1	ppm/°C
OUTPUT	Γ						
V _{OH}	Positive rail headroom	$R_L = 10k\Omega$ to $V_S / 2$			10.5	15	mV
V _{OL}	Negative rail headroom	$R_L = 10k\Omega$ to $V_S / 2$			8.5	15	mV
C _L Drive	Load capacitance drive	V _O = 100mV step, Overshoot < 20%	6		200		pF
Z _O	Closed-loop output impedance	f = 10kHz			200		Ω
sc	Short-circuit current	V _S = 5.5V			±33		mA
FREQUE	ENCY RESPONSE						
3W	Bandwidth, –3dB	$V_{IN} = 10 \text{mV}_{pk-pk}$			125		kHz
THD + N	Total harmonic distortion + noise	V_S = 5.5V, V_{CM} = 2.75V, V_O = 1 V_{RM} f = 1kHz, 80kHz measurement BW	_S , R _L = 100kΩ		0.02		%
EMIRR	Electro-magnetic interference rejection ratio	f = 1GHz, V _{IN_EMIRR} = 100mV			100		dB
SR	Slew rate	$V_S = 5V$, $V_O = 2V$ step			0.20		V/µs
	Settling time	To 0.1%, $V_S = 5.5V$, $V_{STEP} = 2V$, C_L			18		
s		To 0.01%, $V_S = 5.5V$, $V_{STEP} = 2V$, C	, V _{STEP} = 2V, C _L = 10pF		33		μs
3	Settling time	To 0.1%, $V_S = 5.5V$, $V_{OUT_STEP} = 4V$	/, C _L = 10pF	26			μο
	Octaing time	To 0.01%, $V_S = 5.5V$, $V_{OUT_STEP} = 4$	IV, C _L = 10pF		43		
	Overload recovery	V _{STEP} = V _S / G			23.2		μs
REFERE	NCE INPUT						
REF - V _{IN}	Input voltage range	V _S = 5.5V		(V-)		(V+)	V
REF - G	Reference gain to output				1		V/V

5



6.5 Electrical Characteristics - INA500A (続き)

For $V_S = (V+) - (V-) = 1.7V$ to 5.5V (±0.85V to ±2.75V) at $T_A = 25^{\circ}$ C, $V_{REF} = V_S / 2$, G = 1, $R_L = 100k\Omega$ connected to $V_S / 2$, $V_{CM} = (V_{IN+} + V_{IN-}) / 2 = V_S / 2$, $V_{IN} = (V_{IN+} - V_{IN-}) = 0$ V and $V_{OUT} = V_S / 2$ (unless otherwise noted)

CIVI	PARAMETER	TEST CONDITIONS		MIN	TYP	MAX	UNIT
REF - GE	Reference gain error ⁽²⁾	V _S = 5.5V	V _S = 5.5V		±0.005	±0.02	%
POWER	SUPPLY	1				1	
Vs	Power-supply voltage	Dual-supply	Qual-supply			±2.75	V
		V _S = 1.7V	v _S = 1.7V		14.5		μA
IQ	Quiescent current V _S = 5.5V			13.5	18.5	^	
		V _S = 5.5V	T _A = -40°C to 125°C			19.5	μA

- (1) Offset drifts are uncorrelated.
- (2) Minimum and maximum values are specified by characterization.
- (3) RTO stands for Referred to Output

資料に関するフィードバック (ご意見やお問い合わせ) を送信

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Product Folder Links: INA500



6.6 Electrical Characteristics - INA500B

For $V_S = (V+) - (V-) = 1.7V$ to 5.5V (±0.85V to ±2.75V) at $T_A = 25^{\circ}C$, $V_{MID} = [(V+) + (V-)] / 2$, G = 0.5, $V_{REF} = V_{MID}$, $R_L = 100k\Omega$ connected to V_{MID} , $V_{CM} = [(V_{IN+}) + (V_{IN-})] / 2 = V_{MID}$, $V_{IN} = (V_{IN+}) - (V_{IN-}) = 0V$ and $V_{OUT} = V_{MID}$ (unless otherwise noted)

noted)							
	PARAMETER	TEST CONDITIO	ONS	MIN	TYP	MAX	UNIT
OFFSET	1	I	I			1	
	Offset voltage, RTO	V _S = 5.5V	T _A = 25°C		±0.50	±2.6	mV
V _{OSO}	Offset voltage over T,	V _S = 5.5V	$T_A = -40^{\circ}\text{C to } 125^{\circ}\text{C}$			±2.7	mV
	Offset temp drift, RTO ⁽¹⁾	V _S = 5.5V	$T_A = -40^{\circ}\text{C to } 125^{\circ}\text{C}$		±1.4	6.6	μV/°C
PSRR	Power-supply rejection ratio	V _S = 1.7V to 5.5V	T _A = 25°C		40	150	μV/V
INPUT IN	/IPEDANCE						
R _{IN-DM}	Differential Resistance				2880		kΩ
R _{IN-CM}	Common-mode Resistance				1080		kΩ
INPUT V	OLTAGE						
V _{CM}	Input common-mode Range	V _{REF} = V _{MID}		3*(V-) - 2*(V _{REF})		3*(V+) – 2*(V _{REF})	٧
CMRR DC	Common-mode rejection ratio, RTO	$V_{CM} = [3*(V_{-}) - 2*(V_{REF})] \text{ to } [3*(V_{+}) - 2*(V_{REF}) - 2.1]$	V _S = 5.5V, V _{REF} = V _{MID}	77	89		dB
CMRR DC	Common-mode rejection ratio, RTO	$V_{CM} = [3*(V-) - 2*(V_{REF})]$ to $[3*(V+) - 2*(V_{REF})]$	V _S = 5.5V, V _{REF} = V _{MID}	62	79		dB
NOISE V	OLTAGE		l l				
_	Output voltage noise		f = 1kHz		200		\ // .\
e _{NI}	density		f = 10kHz		190		nV/√ Hz
E _{NI}	Output voltage noise	f _B = 0.1Hz to 10Hz			7.5		μV _{PP}
GAIN			<u>'</u>				
GE	Gain error ⁽²⁾	V _{REF} = V _{MID}	V _O = (V–) + 0.1V to (V+) – 0.1V		±0.003	±0.075	%
	Gain drift vs temperature ⁽²⁾	G = 0.5	T _A = -40°C to 125°C			±1	ppm/°C
OUTPUT						•	
V _{OH}	Positive rail headroom	$R_L = 10k\Omega$ to V_{MID}			10	25	mV
V _{OL}	Negative rail headroom	$R_L = 10k\Omega$ to V_{MID}			8	20	mV
C _L Drive	Load capacitance drive	V _O = 100mV step, Overshoot < 20%			120		pF
Z _O	Closed-loop output impedance	f = 10kHz			165		Ω
I _{SC}	Short-circuit current	V _S = 5.5V			±35		mA
FREQUE	NCY RESPONSE		1			"	
BW	Bandwidth, –3dB		V _{IN} = 10mV _{pk-pk}		135		kHz
THD + N	Total harmonic distortion + noise	V_S = 5.5V, V_{CM} = 2.75V, V_O = 1 V_{RMS} , f = 1kHz, 80kHz measurement BW	R _L = 100kΩ		0.017		%
EMIRR	Electro-magnetic interference rejection ratio	f = 1GHz, V _{IN_EMIRR} = 100mV			95		dB
SR	Slew rate	$V_S = 5V$, $V_O = 2V$ step			0.18		V/µs
	Cattling time	To 0.1%, V _S = 5.5V, V _{STEP} = 2V, C _L =	To 0.1%, $V_S = 5.5V$, $V_{STEP} = 2V$, $C_L = 10pF$		21		
	Settling time	To 0.01%, $V_S = 5.5V$, $V_{STEP} = 2V$, $C_L = 10pF$			34		
t _S	To 0.1%, V _S = 5.5V, V _{OUT_STEP} = 4V, C _L = 10p		C _L = 10pF		30		μs
	Settling time	To 0.01%, V _S = 5.5V, V _{OUT_STEP} = 4V	', C _L = 10pF		45		
	Overload recovery	V _{STEP} = V _S / G			24		μs
REFERE	NCE INPUT	•	'			<u>'</u>	
REF - V _{IN}	Input voltage range	V _S = 5.5V		(V-)		(V+)	V
REF - G	Reference gain to output				1		V/V



For $V_S = (V+) - (V-) = 1.7V$ to 5.5V (±0.85V to ±2.75V) at $T_A = 25^{\circ}$ C, $V_{MID} = [(V+) + (V-)] / 2$, G = 0.5, $V_{REF} = V_{MID}$, $R_L = 100$ k Ω connected to V_{MID} , $V_{CM} = [(V_{IN+}) + (V_{IN-})] / 2 = V_{MID}$, $V_{IN} = (V_{IN+}) - (V_{IN-}) = 0$ V and $V_{OUT} = V_{MID}$ (unless otherwise noted)

	PARAMETER	TEST CONDITIONS		MIN	TYP	MAX	UNIT
REF - GE	Reference gain error ⁽²⁾	V _S = 5.5V	V _S = 5.5V		±0.002	±0.025	%
POWER	SUPPLY					•	
Vs	Power-supply voltage	Dual-supply		±0.85		±2.75	V
IQ	Quiescent current	V _S = 1.7V			15		μΑ
	Quiescent current	/ _S = 5.5V			14	19	^
IQ	Quiescent current	V _S = 5.5V	9			20	μA

⁽¹⁾ Offset drifts are uncorrelated.

English Data Sheet: SBOSAI9

⁽²⁾ Minimum and maximum values are specified by characterization.



6.7 Electrical Characteristics - INA500C

For $V_S = (V+) - (V-) = 1.7V$ to 5.5V (±0.85V to ±2.75V) at $T_A = 25^{\circ}C$, $V_{MID} = [(V+) + (V-)] / 2$, G = 0.25, $V_{REF} = V_{MID}$, $R_L = 100k\Omega$ connected to V_{MID} , $V_{CM} = [(V_{IN+}) + (V_{IN-})] / 2 = V_{MID}$, $V_{IN} = (V_{IN+}) - (V_{IN-}) = 0V$ and $V_{OUT} = V_{MID}$ (unless otherwise noted)

noted)	PARAMETER	TEST CONDITION	ONS	MIN	TYP	MAX	UNIT
OFFSET		1231 GONDING		Mille		IIIAA	J.1117
OFFSET	Offset voltage, RTO	V _S = 5.5V	T _A = 25°C		±0.40	±2.2	mV
V _{oso}	Offset voltage over T,	V _S = 5.5V	T _A = -40°C to 125°C		20.10	±2.3	mV
	Offset temp drift, RTO ⁽¹⁾	V _S = 5.5V	T _A = -40°C to 125°C		±1.1	5.5	μV/°C
PSRR	Power-supply rejection ratio	V _S = 1.7V to 5.5V	T _A = 25°C		40	130	μV/V
INPUT II	MPEDANCE	<u> </u>					
R _{IN-DM}	Differential Resistance				3360		kΩ
R _{IN-CM}	Common-mode Resistance				1050		kΩ
NPUT V	OLTAGE						
V _{CM}	Input common-mode Range	V _{REF} = V _{MID}		5*(V-) - 4*(V _{REF})		5*(V+) – 4*(V _{REF})	V
CMRR DC	Common-mode rejection ratio, RTO	V _{CM} = [5*(V-) - 4*(V _{REF})] to [5*(V+) - 4*(V _{REF}) - 3.5]	V _S = 5.5V, V _{REF} = V _{MID}	77.7	85		dB
CMRR DC	Common-mode rejection ratio, RTO	$V_{CM} = [5*(V-) - 4*(V_{REF})]$ to $[5*(V+) - 4*(V_{REF})]$	V _S = 5.5V, V _{REF} = V _{MID}	70			dB
NOISE V	/OLTAGE						
	Output voltage noise		f = 1kHz		150		р\//-/П
e _{NI}	density		f = 10kHz		140		nV/√ H :
E _{NI}	Output voltage noise	f _B = 0.1Hz to 10Hz			7.5		μV _{PP}
GAIN			1				
GE	Gain error ⁽²⁾	V _{REF} = V _{MID}	V _O = (V–) + 0.1 V to (V+) – 0.1V		±0.003	±0.1	%
	Gain drift vs temperature ⁽²⁾	G = 0.5	T _A = -40°C to 125°C			±1	ppm/°0
OUTPUT	Ī						
V _{OH}	Positive rail headroom	$R_L = 10k\Omega$ to V_{MID}			15	25	mV
V _{OL}	Negative rail headroom	$R_L = 10k\Omega$ to V_{MID}			15	20	mV
C _L Drive	Load capacitance drive	O = 100mV step, Overshoot < 20%			100		pF
Z _O	Closed-loop output impedance	= 10kHz			180		Ω
I _{sc}	Short-circuit current	V _S = 5.5V			±30		mA
FREQUE	ENCY RESPONSE						
BW	Bandwidth, –3dB		V _{IN} = 10mV _{pk-pk}		160		kHz
THD + N	Total harmonic distortion + noise	V_S = 5.5V, V_{CM} = 2.75V, V_O = 1 V_{RMS} , f = 1kHz, 80kHz measurement BW	R _L = 100kΩ		0.017		%
EMIRR	Electro-magnetic interference rejection ratio	f = 1GHz, V _{IN_EMIRR} = 100mV			105		dB
SR	Slew rate	V _S = 5V, V _O = 2V step			0.19		V/µs
	Settling time	To 0.1%, $V_S = 5.5V$, $V_{STEP} = 2V$, $C_L =$	10pF		20		
to	Jeaning unie	To 0.01%, $V_S = 5.5V$, $V_{STEP} = 2V$, C_L	= 10pF		32		116
ts	Settling time	To 0.1%, $V_S = 5.5V$, $V_{OUT_STEP} = 4V$,			26		μs
	Octaing time	To 0.01%, V _S = 5.5V, V _{OUT_STEP} = 4V	', C _L = 10pF		40		
	Overload recovery	V _{STEP} = V _S / G			23.2		μs
REFERE	NCE INPUT						
REF - V _{IN}	Input voltage range	V _S = 5.5V, V _{REF} = V _{MID}		(V-)		(V+)	V
REF - G	Reference gain to output			,	1		V/V



For $V_S = (V+) - (V-) = 1.7V$ to 5.5V (±0.85V to ±2.75V) at $T_A = 25^{\circ}C$, $V_{MID} = [(V+) + (V-)] / 2$, G = 0.25, $V_{REF} = V_{MID}$, $R_L = 100k\Omega$ connected to V_{MID} , $V_{CM} = [(V_{IN+}) + (V_{IN-})] / 2 = V_{MID}$, $V_{IN} = (V_{IN+}) - (V_{IN-}) = 0V$ and $V_{OUT} = V_{MID}$ (unless otherwise noted)

	PARAMETER	TE	TEST CONDITIONS		TYP	MAX	UNIT
REF - GE	Reference gain error ⁽²⁾	V _S = 5.5V	V _S = 5.5V		±0.002	±0.02	%
POWER	SUPPLY						
Vs	Power-supply voltage	Dual-supply	Dual-supply			±2.75	V
IQ	Quiescent current	V _S = 1.7V	V _S = 1.7V		15		μΑ
1.	Quioscont current	V _S = 5.5V	' _S = 5.5V		14	19	μA
IQ	Quiescent current $V_S = 5.5V$ $T_A = -40^{\circ}C$ to		T _A = -40°C to 125°C			20	μΑ

⁽¹⁾ Offset drifts are uncorrelated.

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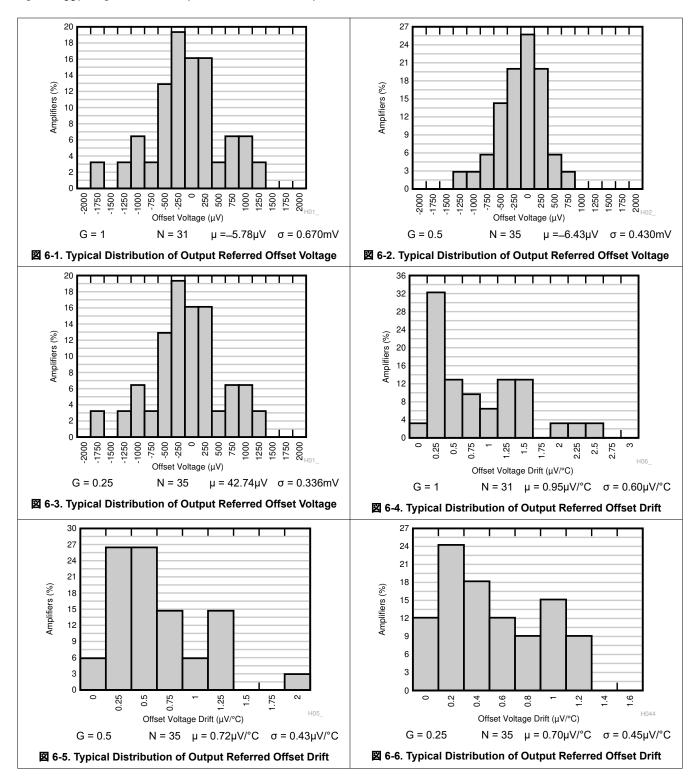
10

Product Folder Links: INA500

⁽²⁾ Minimum and maximum values are specified by characterization.

6.8 Typical Characteristics

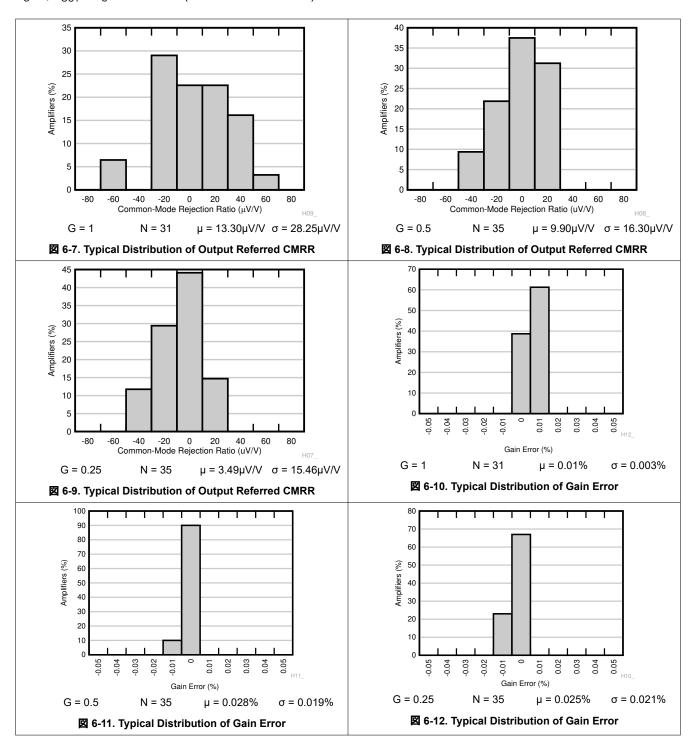
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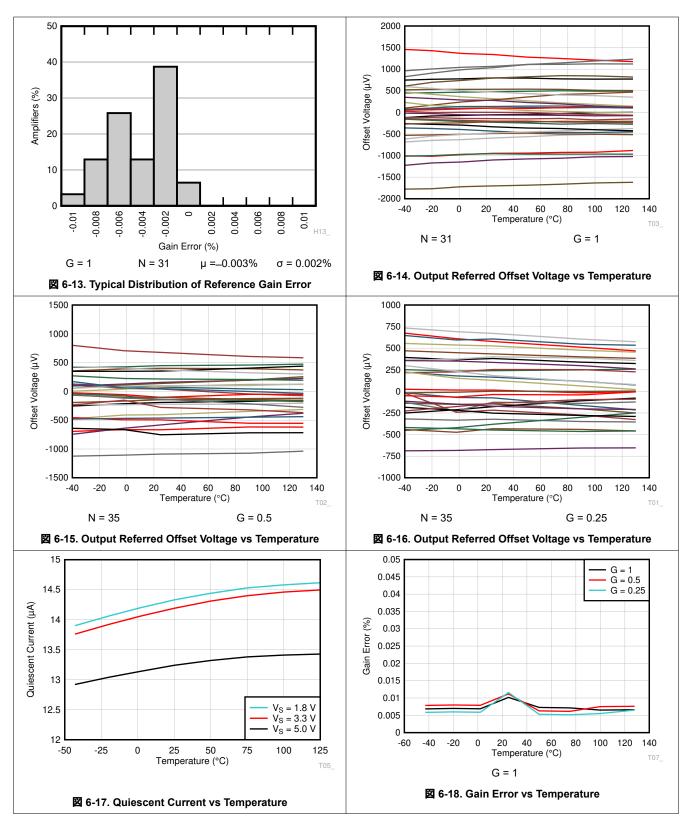
English Data Sheet: SBOSAI9



at $T_A = 25^{\circ}C$, $V_S = (V+) - (V-) = 5.5V$, $V_{IN} = (V_{IN+} - V_{IN-}) = 0V$, $R_L = 10k\Omega$, $C_L = 10pF$, $V_{REF} = V_S / 2$, $V_{CM} = (V_{IN+} + V_{IN-}) / 2 = V_S / 2$, $V_{OUT} = V_S / 2$ and G = 1 (unless otherwise noted)



at $T_A = 25^{\circ}C$, $V_S = (V+) - (V-) = 5.5V$, $V_{IN} = (V_{IN+} - V_{IN-}) = 0V$, $R_L = 10k\Omega$, $C_L = 10pF$, $V_{REF} = V_S / 2$, $V_{CM} = (V_{IN+} + V_{IN-}) / 2 = V_S / 2$, $V_{OUT} = V_S / 2$ and G = 1 (unless otherwise noted)



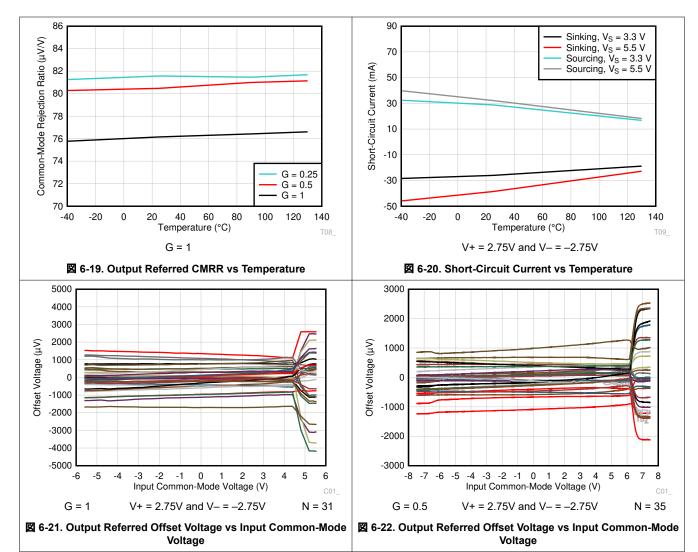
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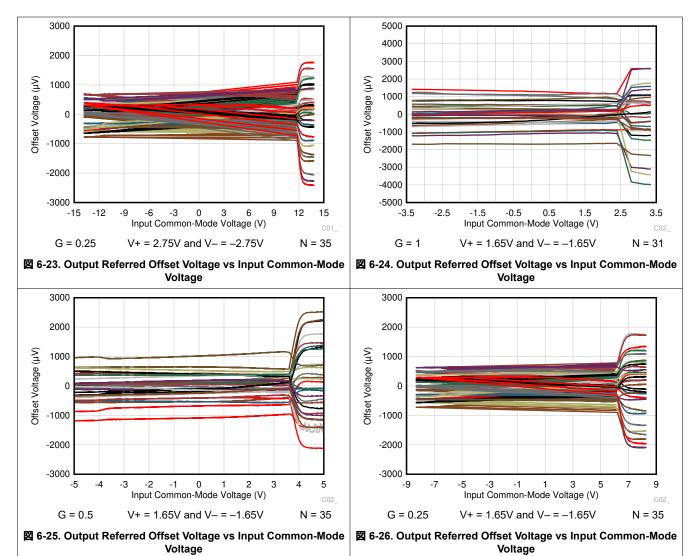
13



at $T_A = 25^{\circ}C$, $V_S = (V+) - (V-) = 5.5V$, $V_{IN} = (V_{IN+} - V_{IN-}) = 0V$, $R_L = 10k\Omega$, $C_L = 10pF$, $V_{REF} = V_S / 2$, $V_{CM} = (V_{IN+} + V_{IN-}) / 2 = V_S / 2$, $V_{OUT} = V_S / 2$ and G = 1 (unless otherwise noted)



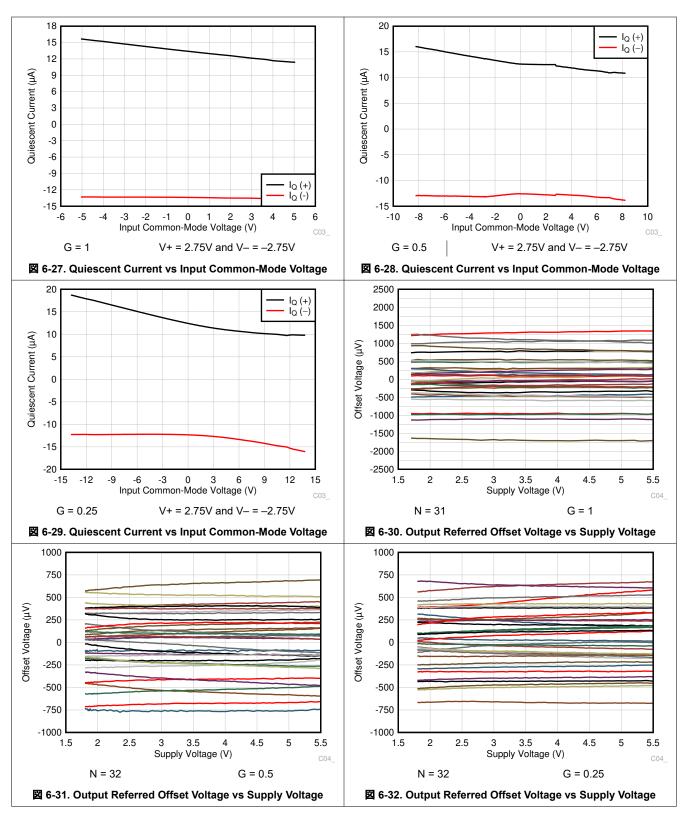
at $T_A = 25^{\circ}C$, $V_S = (V+) - (V-) = 5.5V$, $V_{IN} = (V_{IN+} - V_{IN-}) = 0V$, $R_L = 10k\Omega$, $C_L = 10pF$, $V_{REF} = V_S / 2$, $V_{CM} = (V_{IN+} + V_{IN-}) / 2 = V_S / 2$, $V_{OUT} = V_S / 2$ and G = 1 (unless otherwise noted)



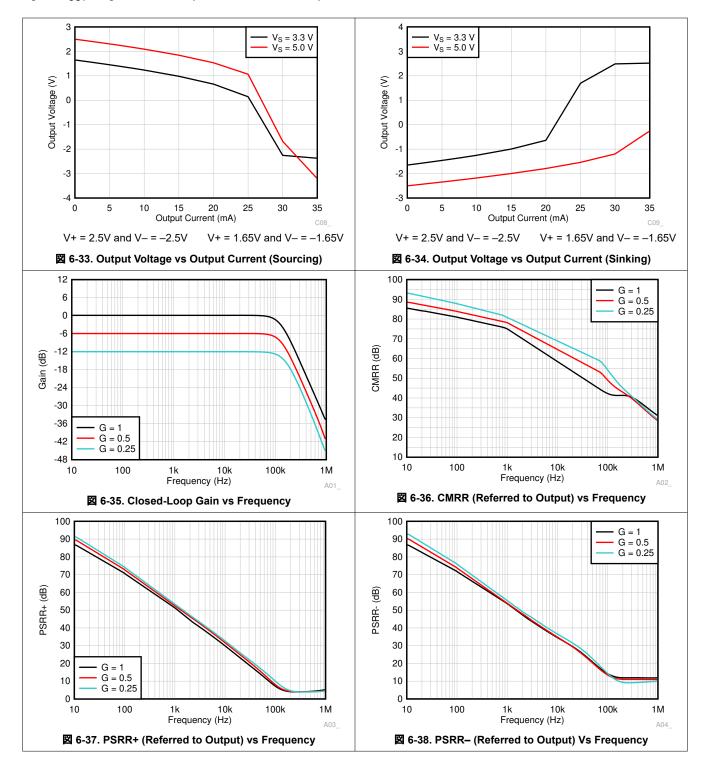
English Data Sheet: SBOSAI9



at $T_A = 25^{\circ}C$, $V_S = (V+) - (V-) = 5.5V$, $V_{IN} = (V_{IN+} - V_{IN-}) = 0V$, $R_L = 10k\Omega$, $C_L = 10pF$, $V_{REF} = V_S / 2$, $V_{CM} = (V_{IN+} + V_{IN-}) / 2 = V_S / 2$, $V_{OUT} = V_S / 2$ and G = 1 (unless otherwise noted)

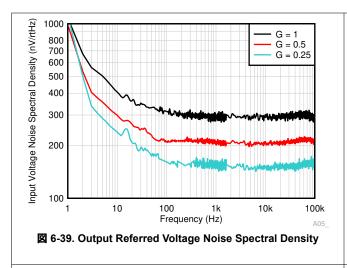


at T_A = 25°C, V_S = (V+) – (V–) = 5.5V, V_{IN} = (V_{IN+} – V_{IN-}) = 0V, R_L = 10k Ω , C_L = 10pF, V_{REF} = V_S / 2, V_{CM} = (V_{IN+} + V_{IN-}) / 2 = V_S / 2, V_{OUT} = V_S / 2 and G = 1 (unless otherwise noted)



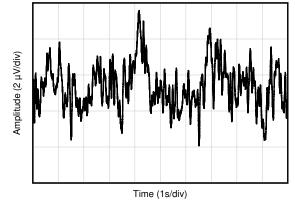


at $T_A = 25^{\circ}C$, $V_S = (V+) - (V-) = 5.5V$, $V_{IN} = (V_{IN+} - V_{IN-}) = 0V$, $R_L = 10k\Omega$, $C_L = 10pF$, $V_{REF} = V_S / 2$, $V_{CM} = (V_{IN+} + V_{IN-}) / 2 = V_S / 2$, $V_{OUT} = V_S / 2$ and G = 1 (unless otherwise noted)



Amplitude (2 µV/div)

図 6-40. Output Referred 0.1 Hz to 10 Hz Voltage Noise in Time Domain



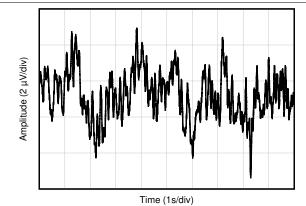
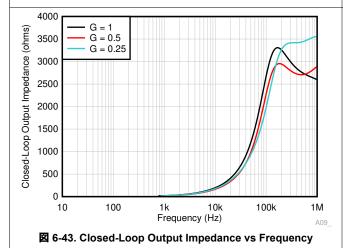


図 6-41. Output Referred 0.1 Hz to 10 Hz Voltage Noise in Time Domain

図 6-42. Output Referred 0.1 Hz to 10 Hz Voltage Noise in Time Domain



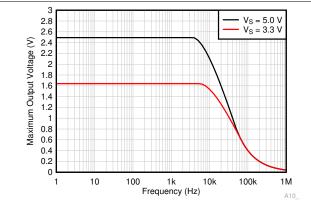
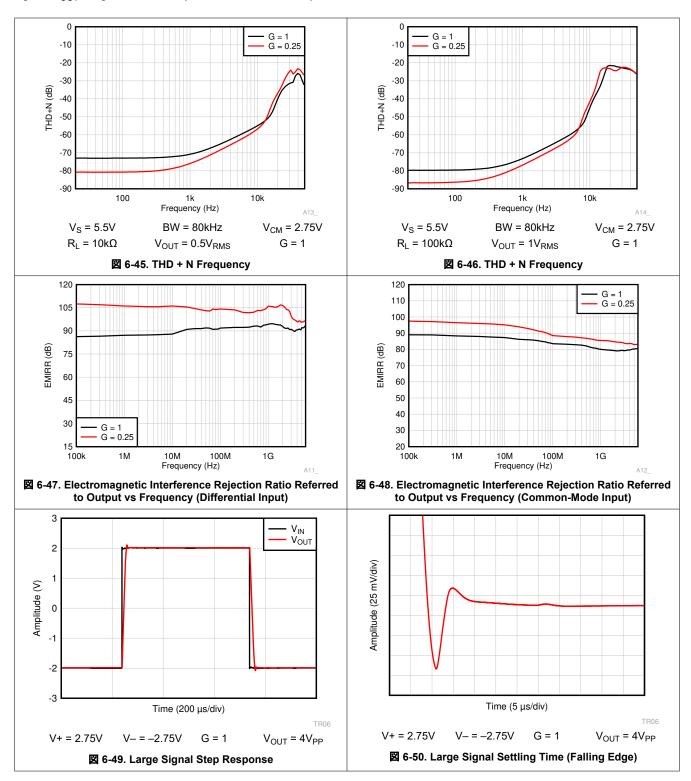


図 6-44. Maximum Output Voltage vs Frequency

A07

at $T_A = 25^{\circ}C$, $V_S = (V+) - (V-) = 5.5V$, $V_{IN} = (V_{IN+} - V_{IN-}) = 0V$, $R_L = 10k\Omega$, $C_L = 10pF$, $V_{REF} = V_S / 2$, $V_{CM} = (V_{IN+} + V_{IN-}) / 2 = V_S / 2$, $V_{OUT} = V_S / 2$ and G = 1 (unless otherwise noted)

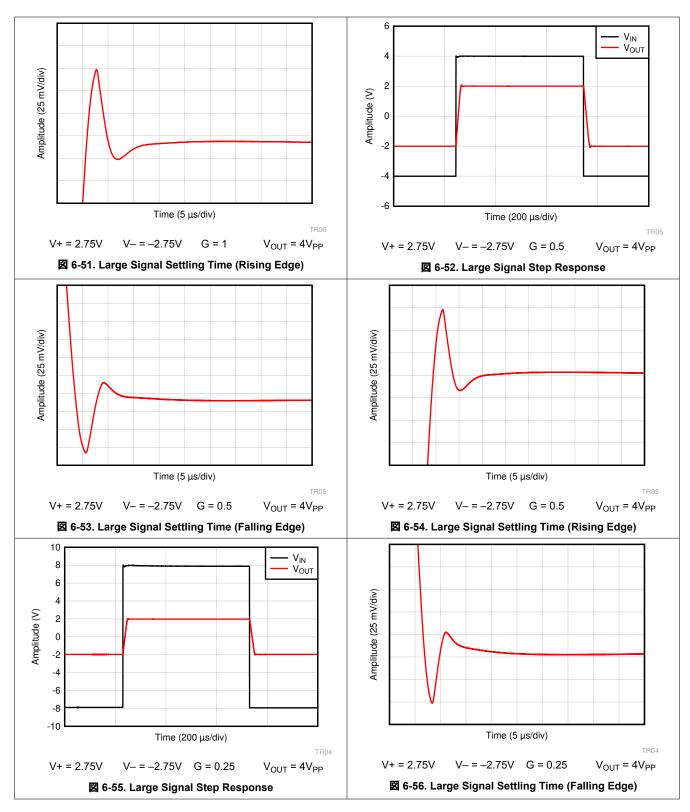


19

Product Folder Links: INA500

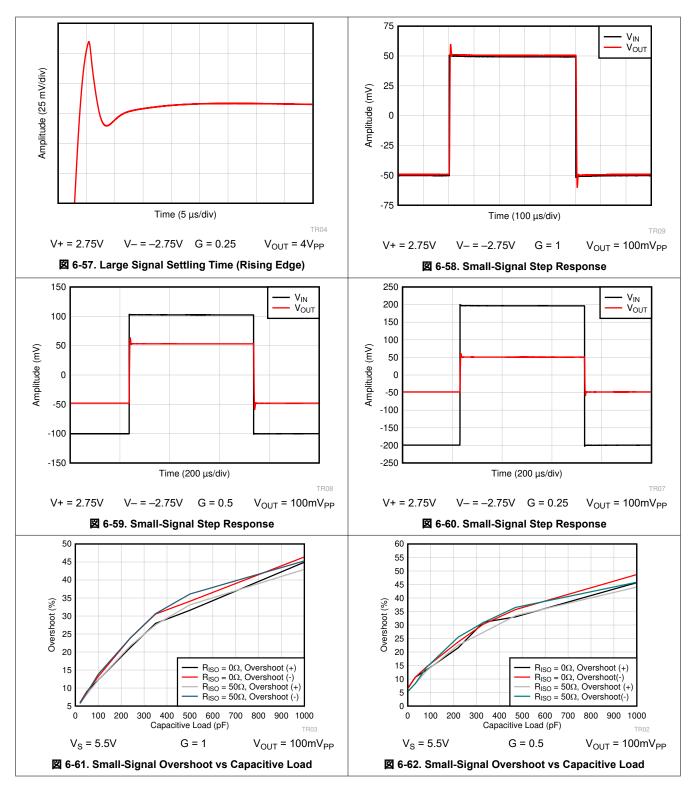


at $T_A = 25^{\circ}C$, $V_S = (V+) - (V-) = 5.5V$, $V_{IN} = (V_{IN+} - V_{IN-}) = 0V$, $R_L = 10k\Omega$, $C_L = 10pF$, $V_{REF} = V_S / 2$, $V_{CM} = (V_{IN+} + V_{IN-}) / 2 = V_S / 2$, $V_{OUT} = V_S / 2$ and G = 1 (unless otherwise noted)



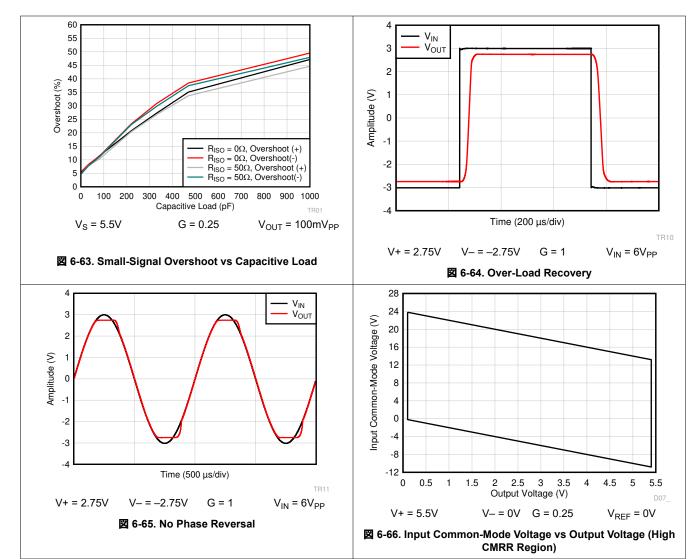
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at $T_A = 25^{\circ}C$, $V_S = (V+) - (V-) = 5.5V$, $V_{IN} = (V_{IN+} - V_{IN-}) = 0V$, $R_L = 10k\Omega$, $C_L = 10pF$, $V_{REF} = V_S / 2$, $V_{CM} = (V_{IN+} + V_{IN-}) / 2 = V_S / 2$, $V_{OUT} = V_S / 2$ and G = 1 (unless otherwise noted)

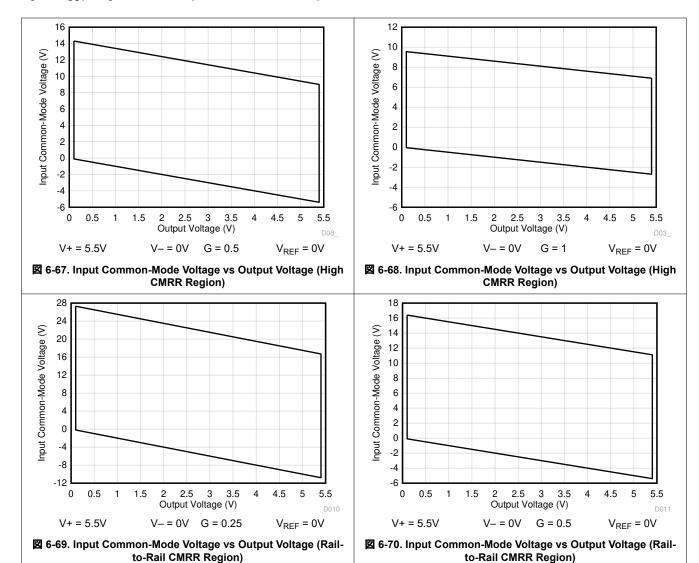




at T_A = 25°C, V_S = (V+) - (V-) = 5.5V, V_{IN} = ($V_{IN+} - V_{IN-}$) = 0V, R_L = 10k Ω , C_L = 10pF, V_{REF} = V_S / 2, V_{CM} = ($V_{IN+} + V_{IN-}$) / 2 = V_S / 2, V_{OUT} = V_S / 2 and G = 1 (unless otherwise noted)

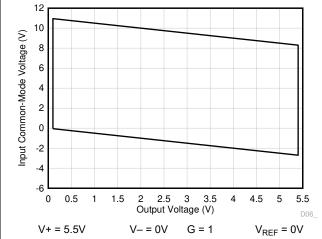


at $T_A = 25^{\circ}C$, $V_S = (V+) - (V-) = 5.5V$, $V_{IN} = (V_{IN+} - V_{IN-}) = 0V$, $R_L = 10k\Omega$, $C_L = 10pF$, $V_{REF} = V_S / 2$, $V_{CM} = (V_{IN+} + V_{IN-}) / 2 = V_S / 2$, $V_{OUT} = V_S / 2$ and G = 1 (unless otherwise noted)





at $T_A = 25^{\circ}C$, $V_S = (V+) - (V-) = 5.5V$, $V_{IN} = (V_{IN+} - V_{IN-}) = 0V$, $R_L = 10k\Omega$, $C_L = 10pF$, $V_{REF} = V_S / 2$, $V_{CM} = (V_{IN+} + V_{IN-}) / 2 = 10k\Omega$ $V_S / 2$, $V_{OUT} = V_S / 2$ and G = 1 (unless otherwise noted)



V+ = 5.5V

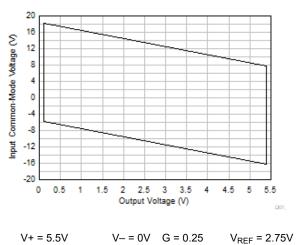
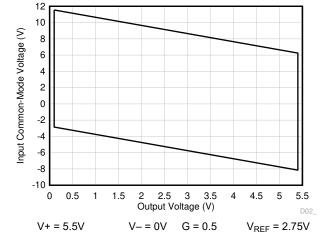


図 6-71. Input Common-Mode Voltage vs Output Voltage (Railto-Rail CMRR Region)

図 6-72. Input Common-Mode Voltage vs Output Voltage (High **CMRR Region)**



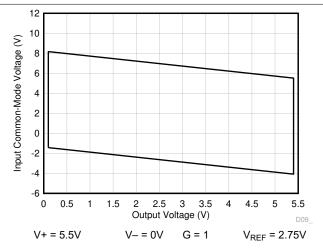
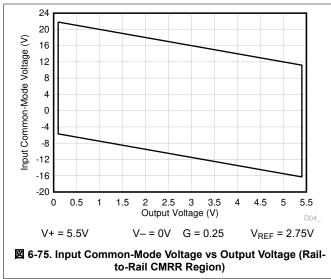


図 6-73. Input Common-Mode Voltage vs Output Voltage (High **CMRR Region)**

図 6-74. Input Common-Mode Voltage vs Output Voltage (High **CMRR Region)**

at $T_A = 25^{\circ}C$, $V_S = (V+) - (V-) = 5.5V$, $V_{IN} = (V_{IN+} - V_{IN-}) = 0V$, $R_L = 10k\Omega$, $C_L = 10pF$, $V_{REF} = V_S / 2$, $V_{CM} = (V_{IN+} + V_{IN-}) / 2 = V_S / 2$, $V_{OUT} = V_S / 2$ and G = 1 (unless otherwise noted)



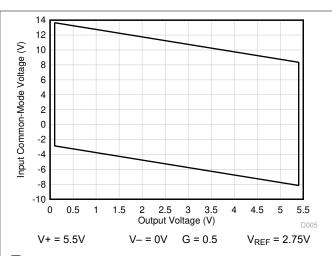
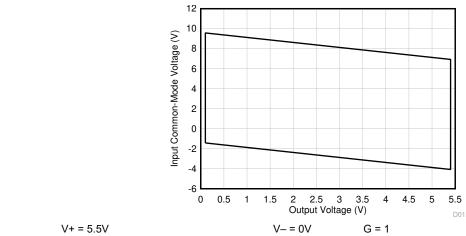


図 6-76. Input Common-Mode Voltage vs Output Voltage (Railto-Rail CMRR Region)



 $V_{REF} = 2.75V$

図 6-77. Input Common-Mode Voltage vs Output Voltage (Rail-to-Rail CMRR Region)

25

Product Folder Links: INA500



7 Detailed Description

7.1 Overview

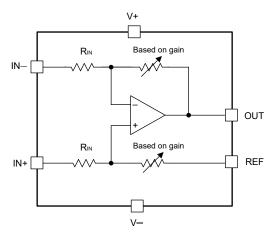
The INA500 is a cost-effective, integrated difference amplifier designed to provide better performance, and smaller solution size for applications employing discrete implementation of difference amplifiers using commodity amplifiers and discrete resistors. The device incorporates one low power operational amplifier and four precision matched integrated resistors. INA500 can be used in 8-bit system without any calibration. Further calibration of offset and gain error at a system level can improve system resolution and accuracy, enabling use in 10-bit and 12-bit systems.

The INA500 is offered in three gain options across three variants. The INA500A version offers gain option of 1, while the INA500B and INA500C versions offer gain options of 0.50 and 0.25 respectively. Optimized for voltage sensing applications, the INA500 offers 75dB of minimum common-mode rejection ratio (CMRR) and $\pm 0.05\%$ of maximum gain error. A high input impedance of $>1M\Omega$ along with just 13.5 μ A of quiescent current is one of the key features of the INA500, which is very useful in single cell battery monitoring applications. All of the errors including offset, offset drift, CMRR and so forth are referred to the output so as to enable easy calculation of signal-to-noise ratio (SNR) and effective number of bits (ENOB) close to the analog-to-digital converter (ADC).

The INA500 gain options are designed for level translation applications that interface with a wide variety of differential (±12V, ±10V, ±5V, and so forth) and single-ended (0V to 12V, 0V to 10V, 0V to 5V, and so forth) high voltage signals into low voltage (0V to 5V, 0V to 3V, 0V to 2.5V, and so forth) ADCs. This would be useful in a variety of end equipments such as Battery testers, Solar string inverters, Power tools, Analog input modules, Battery energy storage systems and so forth where multiple high voltage signals and supply domains are required to be monitored. When routing signals differentially for common-mode noise immunity, the INA500 in G = 1 would be useful in converting the differential signal back to single-ended signal for easy interface to single-ended ADCs while rejecting the common-mode noise. The device also has enough bandwidth of 125kHz to directly drive low-speed (≤10ksps) ADCs.

The INA500 is an excellent choice for use in space-constrained applications such as wearable fitness and activity monitors, cell phones, and so forth as it is offered in ultra-small, 0.8mm² X2SON package. For easy use in industrial applications, it is also available in industry standard packages including SOT-23 and SC70.

7.2 Functional Block Diagram



Note: Input resistors (R_{IN}) values are 1.08M Ω for INA500A, 1.44M Ω for INA500B, and 1.68M Ω for INA500C

図 7-1. INA500A Simplified Internal Schematic

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English Data Sheet: SBOSAI9

7.3 Feature Description

7.3.1 Gain Options and Resistors

The gain value of the INA500 is given by the ratio of feedback resistor and input resistor. The gain options are offered across different device variants as provided in 表 7-1. While the typical value of input and feedback resistors are shown in the following table, it is important to note that these values can vary together by about ±15% while maintaining tighter gain error (tolerance) numbers as specified in the *Electrical Characteristics* table.

AX / - I. Gaill Scieuliuli Iable	表 7-1.	Gain	Selection	Table
----------------------------------	--------	------	-----------	-------

DEVICE	INPUT RESISTOR	FEEDBACK RESISTOR	GAIN
INA500A	1.08ΜΩ	1.08ΜΩ	1
INA500B	1.44ΜΩ	0.72ΜΩ	0.50
INA500C	1.68ΜΩ	0.42ΜΩ	0.25

7.3.1.1 Gain Error and Drift

Gain error in the INA500 is limited by the mismatch of the integrated precision resistors and is specified based on characterization results. Maximum gain error of $\pm 0.05\%$ can be expected for all gains of 1, 0.50, and 0.25. Gain drift in the INA500 is limited by the slight mismatch of the temperature coefficient of the integrated resistors. Since these integrated resistors are precision matched with low temperature coefficient resistors to begin with, the overall gain drift is much better in comparison to discrete implementation of the difference amplifiers built using external resistors. Maximum gain error of $\pm 0.02\%$ can be expected for inputs from the reference pin that sets output common-mode voltage.

7.3.2 Input Common-Mode Voltage Range

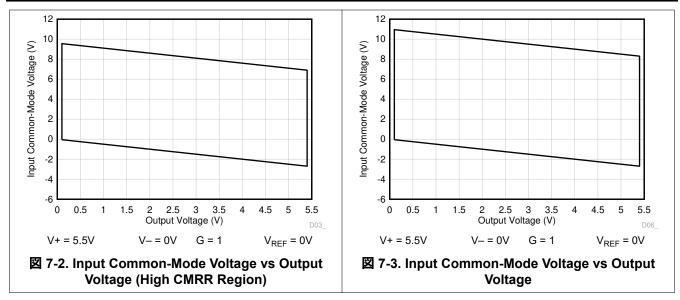
The INA500 difference-amplifier rejects the input common mode. The rejection capability is based on the matching of the internal resistors. The input voltage range of the INA500 is primarily dictated by the signal swing at the op-amp inputs. The INA500 input common-mode voltage range can extend well beyond the supply rails and is a major function of the gain configuration. To maximize performance, it is critical to keep the op-amp inside the INA500 within the linear range for a given combination of gain, reference voltage, and input common-mode voltage for a particular input differential voltage and output swing.

Input common-mode voltage (V_{CM}) vs output voltage graphs (V_{OUT}) in this section outlines the linear performance region of the INA500 for a particular combination of gain and reference voltage values. A good common-mode rejection can be expected when operating with in the limits of the V_{CM} versus V_{OUT} graph. The common-mode range for the INA500 in equation form is outlined in the *Electrical Characteristics* for each gain. The most common operating conditions are outlined graphically in the *Typical Characteristics* section. \boxtimes 7-2 shows the region of operation where a minimum of 75dB CMRR can be achieved. This is referred as the high CMRR region. \boxtimes 7-3 has much wider region of operation with a lower CMRR of 62dB minimum. This is because the input signal crosses over the transition region of the input pairs to achieve rail-to-rail operation.

27

Product Folder Links: INA500





7.3.3 EMI Rejection

The INA500 uses integrated electromagnetic interference (EMI) filtering to reduce the effects of EMI from sources such as wireless communications and densely-populated boards with a mix of analog signal chain and digital components. EMI immunity can be improved with circuit design techniques; the INA500 benefits from these design improvements. Texas Instruments has the ability to accurately measure and quantify the immunity of an operational amplifier over a broad frequency spectrum extending from 10MHz to 6GHz. 区 7-4 shows the results of this testing on the INA500 for differential EMI interference and 区 7-5 shows the results of this testing on the INA500 for common-mode EMI interference. 表 7-2 provides the EMIRR IN+ values for the INA500 at particular frequencies commonly encountered in real-world applications. The EMI Rejection Ratio of Operational Amplifiers application report contains detailed information on the topic of EMIRR performance relating to op amps and is available for download from www.ti.com.

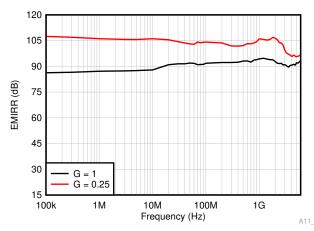


図 7-4. Electromagnetic Interference Rejection Ratio Referred to Output vs Frequency (Differential Input)

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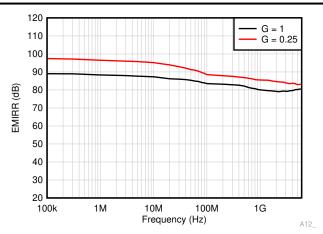


図 7-5. Electromagnetic Interference Rejection Ratio Referred to Output vs Frequency (Common-Mode Input)

表 7-2. INA500 EMIRR for Frequencies of Interest

FREQUENCY	APPLICATION OR ALLOCATION	EMIRR DIFFERNTIAL	EMIRR COMMON-MODE
400MHz	Mobile radio, mobile satellite, space operation, weather, radar, ultra-high frequency (UHF) applications	91dB	83dB
900MHz	Global system for mobile communications (GSM) applications, radio communication, navigation, GPS (to 1.6GHz), GSM, aeronautical mobile, UHF applications		82dB
1.8GHz	GSM applications, mobile personal communications, broadband, satellite, L-band (1GHz to 2GHz)	101dB	80dB
2.4GHz	802.11b, 802.11g, 802.11n, Bluetooth®, mobile personal communications, industrial, scientific and medical (ISM) radio band, amateur radio and satellite, S-band (2GHz to 4GHz)	95dB	78dB
3.6GHz	Radiolocation, aero communication and navigation, satellite, mobile, S-band	88dB	79dB
5GHz	802.11a, 802.11n, aero communication and navigation, mobile communication, space and satellite operation, C-band (4GHz to 8GHz)	94dB	80dB

7.3.4 Typical Specifications and Distributions

Designers often have questions about a typical specification of an amplifier to design a more robust circuit. Due to natural variation in process technology and manufacturing procedures, every specification of an amplifier exhibits some amount of deviation from the ideal value, like an amplifier's offset voltage. These deviations often follow *Gaussian* (*bell curve*), or *normal* distributions, and circuit designers can leverage this information to guard band their system, even when there is not a minimum or maximum specification in the *Electrical Characteristics* table.

29

Product Folder Links: INA500



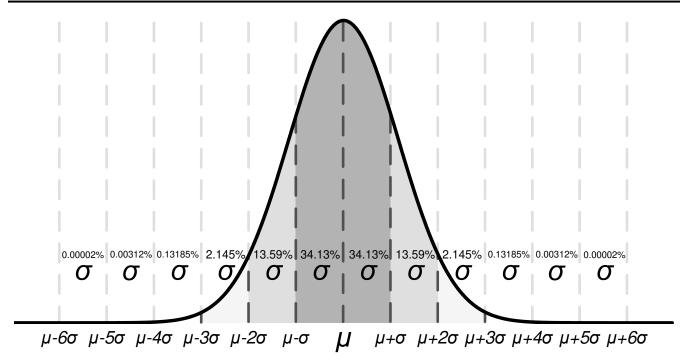


図 7-6. Ideal Gaussian Distribution

 \boxtimes 7-6 shows an example distribution, where μ , or mu, is the mean of the distribution, and where σ , or sigma, is the standard deviation of a system. For a specification that exhibits this kind of distribution, approximately two-thirds (68.26%) of all units can be expected to have a value within one standard deviation, or one sigma, of the mean (from $\mu - \sigma$ to $\mu + \sigma$).

Depending on the specification, values listed in the *typical* column of the *Electrical Characteristics* table are represented in different ways. As a general rule, if a specification naturally has a nonzero mean (for example, like gain bandwidth), then the typical value is equal to the mean (μ). However, if a specification naturally has a mean near zero (like offset voltage), then the typical value is equal to the mean plus one standard deviation (μ + σ) to most accurately represent the typical value.

This chart can be used to calculate approximate probability of a specification in a unit; for example, the INA500A typical offset voltage is $700\mu\text{V}$, so 68.2% of all INA500A devices are expected to have an offset from $-700\mu\text{V}$ to $+700\mu\text{V}$. At 4 σ ($\pm2800\mu\text{V}$), 99.9937% of the distribution has an offset voltage less than $\pm2800\mu\text{V}$, which means 0.0063% of the population is outside of these limits, which corresponds to about 1 in 15,873 units.

Specifications with a value in the minimum or maximum column are verified by TI, and units outside these limits are removed from production material. For example, the INA500A family has a maximum offset voltage of ± 3.5 mV at 25°C, and even though this corresponds to 5σ (equals approximately 1 in 3.5 million units), which is extremely unlikely, TI verifies that any unit with larger offset than ± 3.5 mV are removed from production material.

For specifications with no value in the minimum or maximum column, consider selecting a sigma value of sufficient guard band for the application, and design worst-case conditions using this value. A 6 σ value corresponds to about 1 in 500 million units, which is an extremely unlikely chance, and can be an option as a wide guard band to design a system around. Histograms for some of the important specifications like offset, offset drift, CMRR, gain error are shown in the *Typical Characteristics* section.

In the case of gain error, the INA500 family does not specify a maximum value based on final test but based on characterization as mentioned in the *Electrical Characteristics* table. The corresponding distribution mentioned in \boxtimes 6-10 has a mean of 0.01% and sigma of 0.003%. Hence, the mean plus 6σ value for gain error can be calculated to be approximately 0.03%. When designing for system conditions with 6σ guardband, this method and value can be used to estimate the worst possible gain error.

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However, process variation and adjustments over time can shift typical means and standard deviations, and unless there is a value in the minimum or maximum specification column that is specified based on final test, TI cannot verify the performance of a device. Hence, the maximum gain error spec in the *Electrical Characteristics* table is relaxed beyond 6σ guardband to be $\pm 0.05\%$.

7.3.5 Electrical Overstress

Designers often ask questions about the capability of an operational amplifier to withstand electrical overstress. These questions tend to focus on the device inputs, but can involve the supply voltage pins or even the output pin. Each of these different pin functions have electrical stress limits determined by the voltage breakdown characteristics of the particular semiconductor fabrication process and specific circuits connected to the pin. Additionally, internal electrostatic discharge (ESD) protection is built into these circuits to protect them from accidental ESD events both before and during product assembly.

Having a good understanding of this basic ESD circuitry and the relevance to an electrical overstress event is helpful. \boxtimes 7-7 shows the ESD circuits contained in the INA500 devices. On the input pins, the ESD protection circuitry involves local high impedance diode structures and do not route the ESD current to power supply ESD cell. On the output pin, there are reverse biased diodes to both the power supply rails. These diode structures route the ESD current back to the internal power supply lines, where there is an absorption power supply ESD cell internal to the difference amplifier. On the reference pin, the ESD protection is local and does not route current to the power supply ESD cell.

All of the ESD protection circuitry is intended to remain inactive during normal circuit operation.

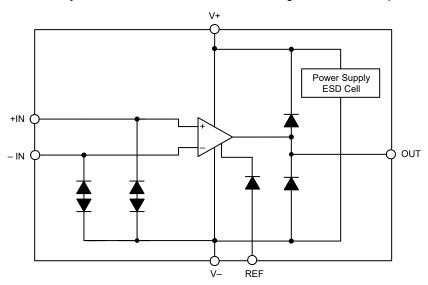


図 7-7. Equivalent Internal ESD Circuitry

7.4 Device Functional Modes

The INA500 has only one functional mode. The device powers on, starts drawing quiescent current and is functional as long as the power supply voltages are in the recommended operating voltage range of 1.7V $(\pm 0.85V)$ to 5.5V $(\pm 2.75V)$. Operational temperature range of INA500 is from -40° C to 125 $^{\circ}$ C.

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31



8 Application and Implementation

注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information

8.1.1 Reference Pin

The output voltage of the INA500 is developed with respect to the voltage on the reference pin (REF). Often in dual-supply operation, REF pin connects to the system ground. However, in single-supply operation, offsetting the output signal to a precise mid-supply level is useful and required (for example, 2.5V in a 5.0V supply environment). To accomplish this level shift, a voltage source must be connected to the REF pin to level-shift the output so that the INA can drive a single-supply ADC. This is accomplished using an external reference buffer configured in unity gain, voltage follower configuration as shown in \boxtimes 8-1.

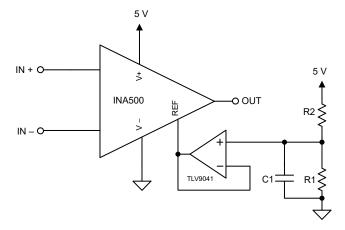


図 8-1. INA500 with External Reference Buffer

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8.2 Typical Applications

8.2.1 Battery Monitoring using Difference Amplifier

The INA500 is an integrated difference amplifier that processes large differential voltages while simultaneously rejecting larger common-mode voltages. The device offers a low power consumption of $13.5\mu A$ (typical) and has a smaller form factor.

With the specifications above, the device is a good fit for portable applications that are powered with single cell or coin-cell batteries. Often, these systems do not need sophisticated battery management technology but a solution that is rather simple and small-size. In a few other systems, battery monitoring ICs are preferred to perform sophisticated functions including cell balancing, protection, voltage and current sensing and so forth but these systems still need a secondary level of protection or redundancy with a simpler and reliable solution for system integrity. It is in these scenarios, the amplifier based battery monitoring application shown below could be quite useful.

☑ 8-2 shows an example circuit that monitors a 12V battery voltage and interfaces it to an ADC that is powered using a 3V power supply. The main advantage for using difference amplifiers in this application is the elimination of ground bounce, which is a common-mode signal, when measuring the battery voltage. These ground bounce signals, when not rejected, are capable of causing errors in the range of few milli-volts to tens or hundreds of milli-volts.

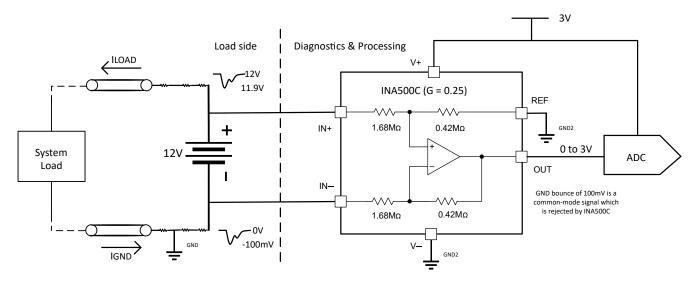


図 8-2. Battery Monitoring Circuitry

33

Product Folder Links: INA500



8.2.1.1 Design Requirements

For this application, the design requirements are as provided in 表 8-1.

表 8-1. Design Requirements

DESCRIPTION	VALUE
Battery voltage	V _{BAT} = 12V
Supply voltage	V _S = 3V
Full-scale range of ADC	$V_{ADC(fs)} = V_{OUT} = 3V$
Quiescent current	30μΑ
Accuracy	8 bits
Common-mode rejection ratio	60dB or a factor of 1000

8.2.1.2 Detailed Design Procedure

This section provides basic calculations for the INA500C difference amplifier with respect to the given design requirements.

Firstly, the 12V battery voltage needs to be attenuated and interfaced to ADC reference voltage of 3V. This requires a $G = \frac{1}{4}$ or 0.25V/V and hence INA500C is chosen for the application.

Gain =
$$\frac{V_{BAT}}{V_{ADC}} = \frac{12}{3} = \frac{1}{4} = 0.25$$
 (1)

The maximum common-mode range of INA500 in a gain of 0.25 is given by,

$$V_{CM MAX} = 5*(V+) - 4*V_{REF} = 5*3 - 4*0 = 15V$$
 (2)

This is well within the requirements for sensing 12V battery voltage and the common-mode rejection ratio (CMRR) referred to output is a minimum of 62dB as per *Electrical Characteristics* table. This corresponds to a attenuation factor of $\frac{1}{1250}$. This helps attenuate the 100mV common-mode error shown in the \boxtimes 8-2 to just 80 μ V.

$$CM_{Err_RTO} = \frac{100mV}{1250} = 80\mu V$$
, when referred to INA500C's output. (3)

Next, INA500C has input impedance of $1.68M\Omega$ as per the *Electrical Characteristics* table. Assuming a full battery voltage of 12V, the input current through the resistor is calculated as,

$$I_{R_{\text{IN}}} = \frac{V_{\text{BAT}}}{R_{\text{IN}}} = \frac{12}{1.68M} = 7.2 \mu A$$
 (4)

This input current through the resistor adds to the amplifier quiescent current of 13.5μA resulting in a total current consumption of 20.7μA, which meets the design requirement of 30μA.

$$I_{total} = I_{R_{IN}} + I_{Q} \tag{5}$$

The next step is to calculate the other error sources in the application. Maximum gain error and offset error as per *Electrical Characteristics* table are 0.05% and 2.5mV for the Gain = 0.25V/V.

Total Error =
$$\sqrt{(0.0005*12)^2 + 0.0025^2} = 6.5 \text{mV}$$
 (6)

For an 8 bit, 3V ADC, V_{LSB} is calculated as,

$$V_{LSB} = \frac{3}{28} = 11.7 \text{mV} \tag{7}$$

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The total error of 6.5mV that was calculated is approximately 0.5LSB of ADC full scale voltage of 3V and hence meets the 8-bit accuracy requirement.

Note, that the errors across temperature are not calculated here but can be easily included in the error analysis based on the drift specifications provided in the *Electrical Characteristics* table as per the application's temperature requirements. These drift errors and noise often do not heavily affect the performance at 8 bit accuracy levels. Finally, calibration of offset and gain error can improve the accuracy beyond 10 to 12 bits as these factors can be the major sources of error in the application.

8.2.1.3 Application Curves

The following typical characteristic curve is for the circuit in 🗵 8-2.

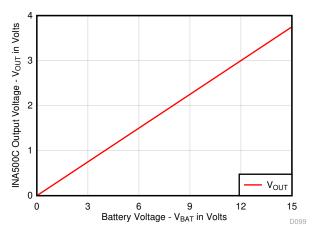


図 8-3. Battery Input Voltage vs INA500C Output Voltage

8.3 Power Supply Recommendations

The nominal performance of the INA500 is specified with a supply voltage of ± 2.75 V and midsupply reference voltage. The device also operates using power supplies from ± 0.85 V (1.7V) to ± 2.75 V (5.5V) and non-midsupply reference voltages with good performance. Many specifications apply from -40°C to 125°C. *Electrical Characteristics* presents parameters that can exhibit significant variance due to operating voltage or temperature.

TI highly recommends to add low-ESR ceramic bypass capacitors (C_{BYP}) between each supply pin and ground. Only one C_{BYP} is sufficient for single supply operation. Place the C_{BYP} as close to the device as possible to reduce coupling errors from noisy or high-impedance power supplies. Please ensure the power supply trace routes through C_{BYP} before reaching the amplifier power supply terminals. For more information, see *Layout Guidelines*.

Parameters can vary with operating voltage and reference voltage. *Typical Characteristics* section can be used to estimate the performance outside of the *Electrical Characteristics* section.

English Data Sheet: SBOSAI9



8.4 Layout

8.4.1 Layout Guidelines

Attention to good layout practices is always recommended. For best operational performance of the device, use the following PCB layout practices:

- Ensure that both input paths are well-matched for source impedance and capacitance to avoid converting common-mode signals into differential signals.
- Use bypass capacitors to reduce the coupled noise by providing low-impedance power sources local to the analog circuitry.
 - Connect low-ESR, 0.1µF ceramic bypass capacitors between each supply pin and ground, placed as close to the device as possible. A single bypass capacitor from V+ to ground is applicable for singlesupply applications.
- Route the input traces as far away from the supply or output traces as possible to reduce parasitic coupling. If
 these traces cannot be kept separate, crossing the sensitive trace perpendicular is much better than crossing
 in parallel with the noisy trace.

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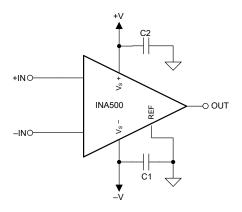
- Place the external components as close to the device as possible.
- Keep the traces as short as possible.

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8.4.2 Layout Example



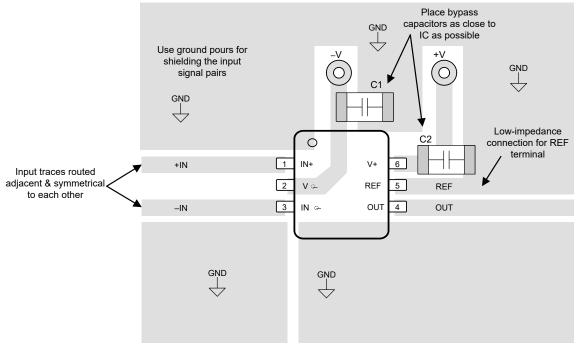


図 8-4. Example Schematic and Associated PCB Layout

37

Product Folder Links: INA500



9 Device and Documentation Support

9.1 Device Support

9.1.1 Development Support

- SPICE-based analog simulation program TINA-TI software folder
- · Analog Engineers Calculator

9.1.1.1 PSpice® for TI

PSpice® for TI is a design and simulation environment that helps evaluate performance of analog circuits. Create subsystem designs and prototype solutions before committing to layout and fabrication, reducing development cost and time to market.

9.2 Documentation Support

9.2.1 Related Documentation

For related documentation see the following:

· Texas Instruments, EMI Rejection Ratio of Operational Amplifiers application note

9.3 ドキュメントの更新通知を受け取る方法

ドキュメントの更新についての通知を受け取るには、www.tij.co.jp のデバイス製品フォルダを開いてください。[通知] をクリックして登録すると、変更されたすべての製品情報に関するダイジェストを毎週受け取ることができます。 変更の詳細については、改訂されたドキュメントに含まれている改訂履歴をご覧ください。

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9.7 用語集

テキサス・インスツルメンツ用語集 この用語集には、用語や略語の一覧および定義が記載されています。

10 Revision History

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

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English Data Sheet: SBOSAI9



Changes from Revision A (January 2024) to Revision B (March 2024)	Page
• Changed the status of DBV, DCK packages of INA500B and INA500C from: preview to: active	2
Added Electrical Characteristics table for gain options of 0.5 and 0.25	4
Added Typical Characteristics graphs for the 0.5 and 0.25 gain options	11
Changes from Revision * (December 2023) to Revision A (January 2024)	Page
Added footnote for Reference gain error in Electrical Characteristics table,	5

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

39

Product Folder Links: INA500

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8-Nov-2025

PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
INA500AIDBVR	Active	Production	SOT-23 (DBV) 6	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	3B4H
INA500AIDBVR.A	Active	Production	SOT-23 (DBV) 6	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	3B4H
INA500AIDCKR	Active	Production	SC70 (DCK) 6	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1RJ
INA500AIDCKR.A	Active	Production	SC70 (DCK) 6	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1RJ
INA500BIDBVR	Active	Production	SOT-23 (DBV) 6	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	3B6H
INA500BIDBVR.A	Active	Production	SOT-23 (DBV) 6	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	3B6H
INA500BIDCKR	Active	Production	SC70 (DCK) 6	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1RK
INA500BIDCKR.A	Active	Production	SC70 (DCK) 6	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1RK
INA500CIDBVR	Active	Production	SOT-23 (DBV) 6	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	3B5H
INA500CIDBVR.A	Active	Production	SOT-23 (DBV) 6	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	3B5H
INA500CIDCKR	Active	Production	SC70 (DCK) 6	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1RL
INA500CIDCKR.A	Active	Production	SC70 (DCK) 6	3000 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 125	1RL

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No. RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.



PACKAGE OPTION ADDENDUM

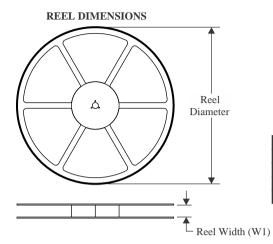
www.ti.com 8-Nov-2025

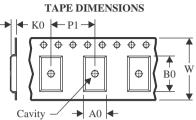
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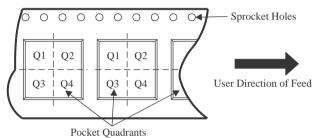
TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

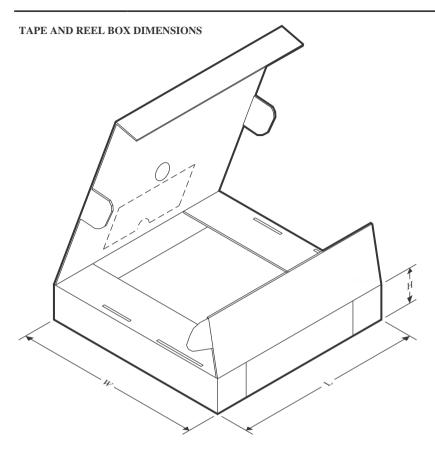


*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
INA500AIDBVR	SOT-23	DBV	6	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
INA500AIDCKR	SC70	DCK	6	3000	178.0	9.0	2.4	2.5	1.2	4.0	8.0	Q3
INA500BIDBVR	SOT-23	DBV	6	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
INA500BIDCKR	SC70	DCK	6	3000	178.0	9.0	2.4	2.5	1.2	4.0	8.0	Q3
INA500CIDBVR	SOT-23	DBV	6	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
INA500CIDCKR	SC70	DCK	6	3000	178.0	9.0	2.4	2.5	1.2	4.0	8.0	Q3



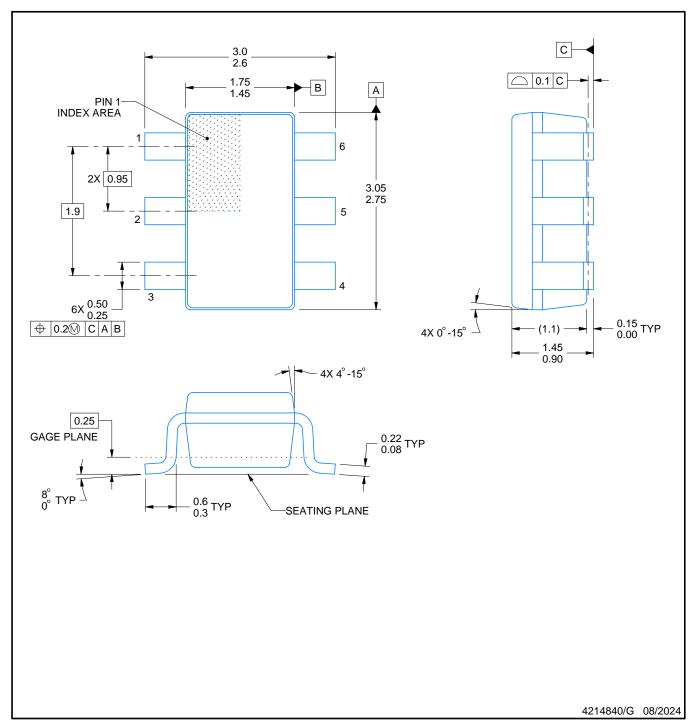
www.ti.com 23-Mar-2024



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
INA500AIDBVR	SOT-23	DBV	6	3000	210.0	185.0	35.0
INA500AIDCKR	SC70	DCK	6	3000	190.0	190.0	30.0
INA500BIDBVR	SOT-23	DBV	6	3000	210.0	185.0	35.0
INA500BIDCKR	SC70	DCK	6	3000	190.0	190.0	30.0
INA500CIDBVR	SOT-23	DBV	6	3000	210.0	185.0	35.0
INA500CIDCKR	SC70	DCK	6	3000	190.0	190.0	30.0





NOTES:

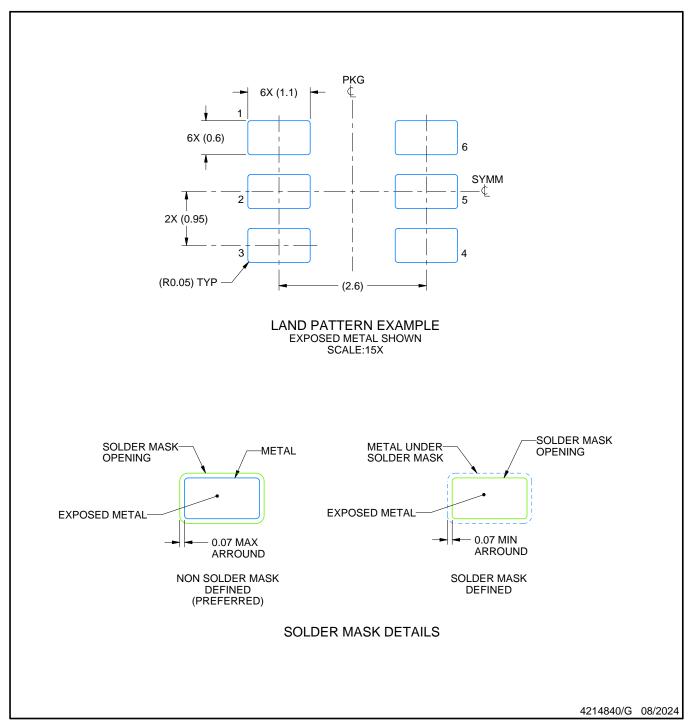
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.25 per side.

- 4. Leads 1,2,3 may be wider than leads 4,5,6 for package orientation.
- 5. Refernce JEDEC MO-178.



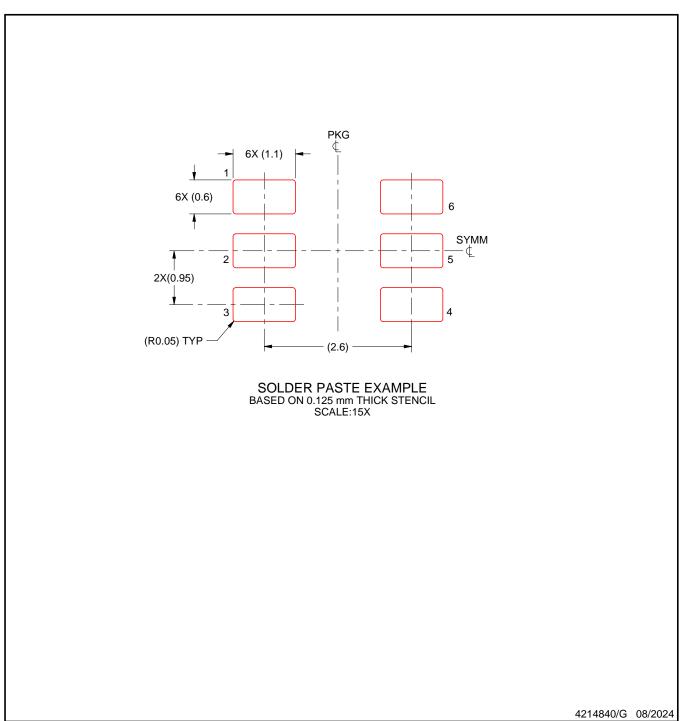


NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



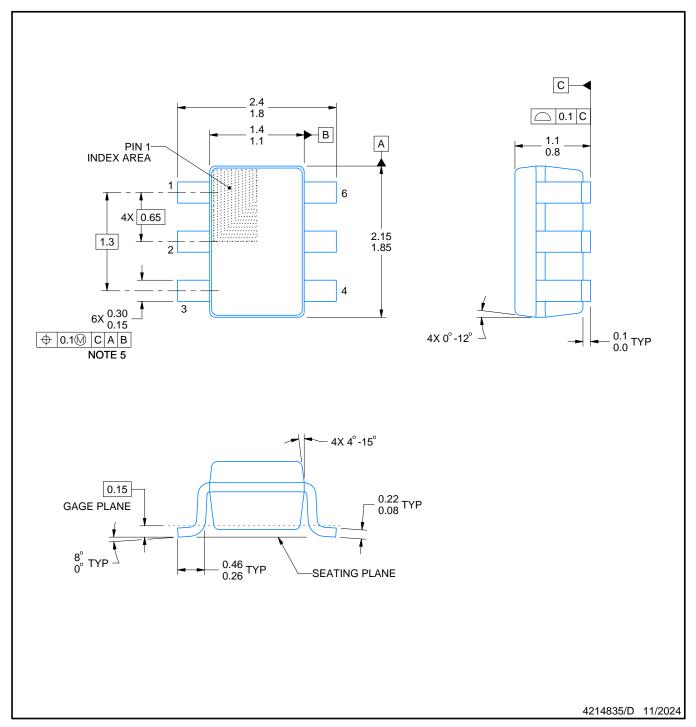


NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







NOTES:

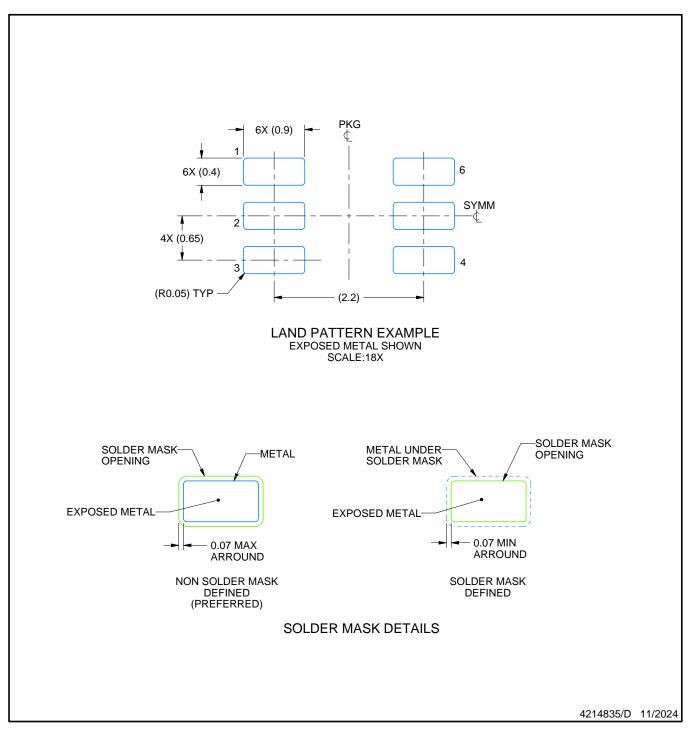
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.

 4. Falls within JEDEC MO-203 variation AB.



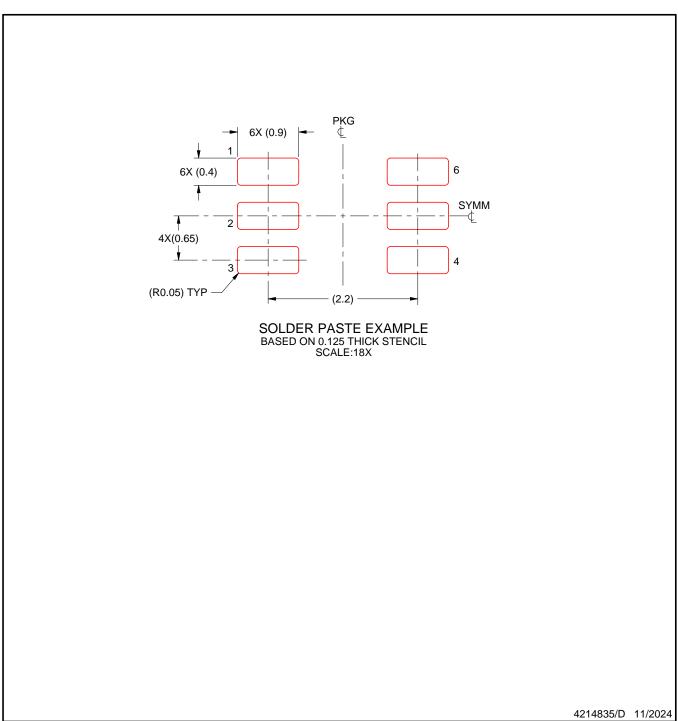


NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.

6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.





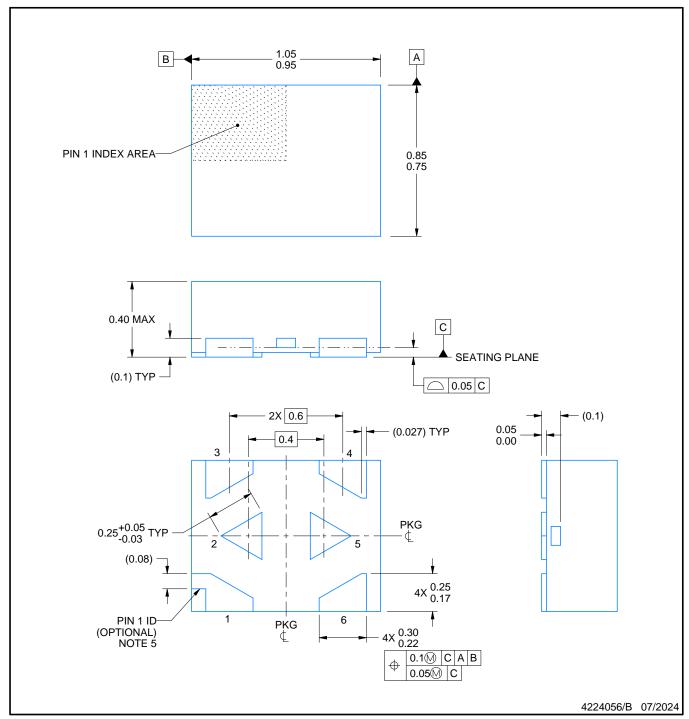
NOTES: (continued)

- 7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 8. Board assembly site may have different recommendations for stencil design.





PLASTIC SMALL OUTLINE - NO LEAD



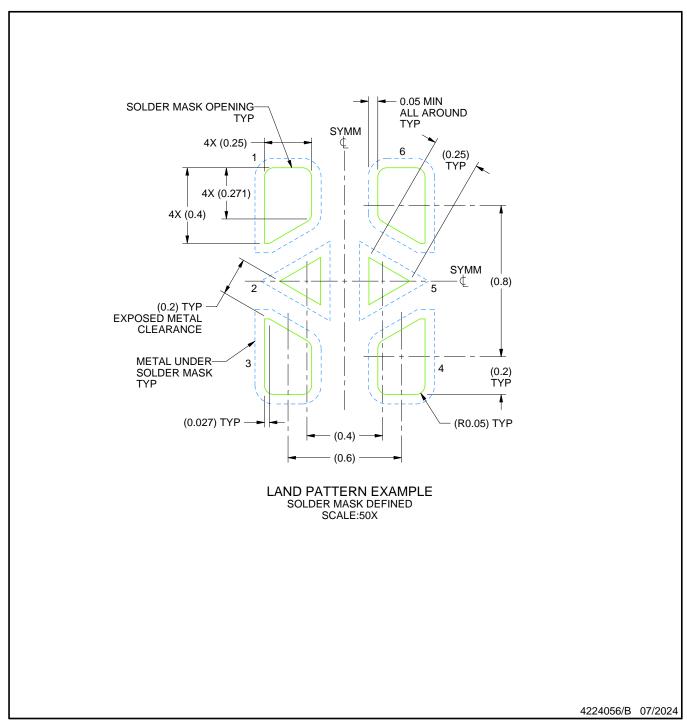
NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. The package thermal pads must be soldered to the printed circuit board for optimal thermal and mechanical performance.

 4. The size and shape of this feature may vary.
- 5. Features may not exist. Recommend use of pin 1 marking on top of package for orientation purposes.



PLASTIC SMALL OUTLINE - NO LEAD



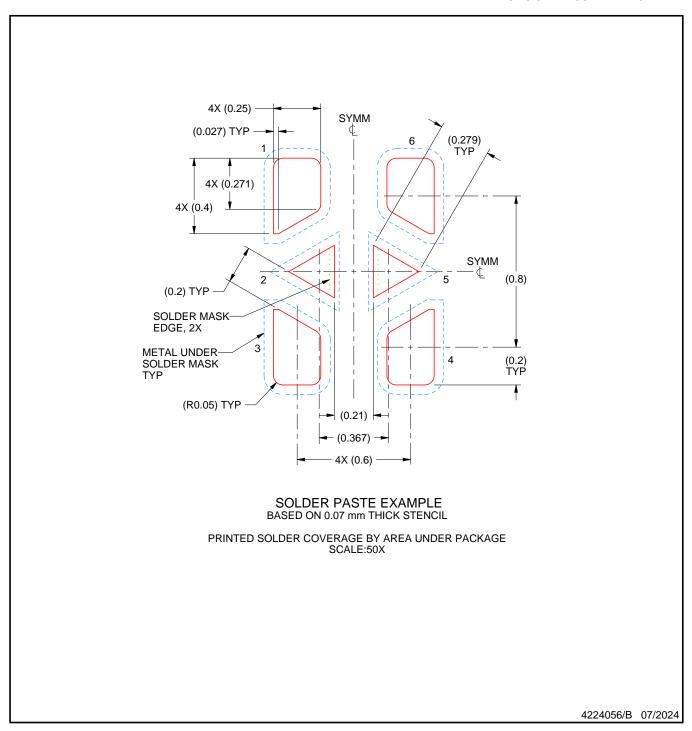
NOTES: (continued)



^{6.} This package is designed to be soldered to a thermal pads on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

^{7.} Vias are optional depending on application, refer to device data sheet. If some or all are implemented, recommended via locations are shown.

PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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最終更新日: 2025 年 10 月